## IN THE CLAIMS:

- 1. (Currently Amended) A thin-film magnetic head having an MR head portion containing magnetoresistive elements, wherein the following layers are formed on at least the surface of said MR head portion facing a recording medium:
- (A) a lower layer eomposed of comprising a thin film having a composition represented by the formula selected from the group consisting of:

formula (i): 
$$SiC_XH_YO_ZN_WF_TB_UP_V$$

where X = 0.5 - 26, Y = 0.5 - 13, Z = 0 - 6, W = 0 - 6, U = 0 - 1 and V = 0 - 1, in terms of atomic ratio, and

where Y = 0.0001 - 0.7, Z = 0 - 6, W = 0 - 6, T = 0 - 6, U = 0 - 1 and V = 0 - 1, in terms of atomic ratio; and

(B) an upper layer composed of comprising a diamond-like thin film having a composition represented by the following formula: CH<sub>a</sub> O<sub>b</sub> N<sub>c</sub> F<sub>d</sub> B<sub>e</sub> P<sub>f</sub>

where a = 0 - 0.7, b = 0 - 1, c = 0 - 1, d = 0 - 1, e = 0 - 1 and f = 0 - 1, in terms of atomic ratio.

- 2. (Original) The magnetic head according to Claim 1, wherein the overall thickness of said lower layer and said upper layer is 40 Å or less.
- 3. (Currently Amended) The magnetic head according to Claim 1 or 2, wherein said lower layer and said upper layer are formed by vapor deposition method.
- 4. (Currently Amended) The magnetic head according to Claim 1 or 2, wherein said lower layer has a thickness of 20 Å or less, and said upper layer has a thickness of 20 Å or less.

- 5. (Currently Amended) A method for producing a thin-film magnetic head, wherein comprising conducting vapor deposition is conducted on at least the a surface of said thin-film magnetic head facing a recording medium, in such a manner that to form the following layers are formed thereon:
- (A) a lower layer having a composition represented by the formula selected from the group consisting of:

formula (i):  $SiC_XH_YO_ZN_WF_TB_UP_V$ 

where X = 0.5 - 26, Y = 0.5 - 13, Z = 0 - 6, W = 0 - 6, U = 0 - 1 and V = 0 - 1, in terms of atomic ratio, and

formula (ii): SiH<sub>Y</sub>O<sub>Z</sub>N<sub>W</sub>F<sub>T</sub>B<sub>U</sub>P<sub>V</sub>

where Y = 0.0001 - 0.7, Z = 0 - 6, W = 0 - 6, T = 0 - 6, U = 0 - 1 and V = 0 - 1, in terms of atomic ratio; and

(B) an upper layer composed of comprising a diamond-like thin film having a composition represented by the following formula:  $CH_a O_b N_c F_d B_e P_f$ 

where a = 0 - 0.7, b = 0 - 1, c = 0 - 1, d = 0 - 1, e = 0 - 1 and f = 0 - 1, in terms of atomic ratio.

- 6. (Currently Amended) The method according to Claim 5, wherein comprising conducting deposition is conducted in such a manner that the thickness of said lower layer becomes 20 Å or less, and the thickness of said upper layer becomes Å or less.
- 7. (Currently Amended) The method according to Claim 5, wherein comprising conducting vapor deposition is conducted by applying a negative bias voltage to the thin-film magnetic head.

- 8. (Currently Amended) The method according to Claim 7, wherein comprising conducting said bias voltage is applied by self-bias generated by an applied DC source or an applied radiofrequency power.
- 9. (Original) A magnetic disk device having at least one slider equipped with the thin-film magnetic head according to Claim 1.